

Application/Control No.	Applicant(s)/Patent under Reexamination	nt under	
10/820,468	LOCHER ET AL.		
Examiner	Art Unit		
Stephen J. Stein	1775		

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SEARCHED					
Class	Subclass	Date	Examiner		
428	702	7/23/2005	sıs		
428	220	7/23/2005	SJS		
428	213	7/23/2005	sıs		
428	332	7/23/2005	SJS		
- 117	922	7/23/2005	sıs		
117	944	7/23/2005	sıs		
423	625	7/23/2005	sus		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH (INCLUDING SEAR		
	DATE	EXMR
Inventor Search	7/23/2005	SJS
West Search (USPAT/PGUBS) (Derwent/JPO/EPO)	7/23/2005	SJS